

# One Cell Lithium-ion/Polymer Battery Protection IC

## GENERAL DESCRIPTION

The XB5358A product is a high integration solution for lithium-ion/polymer battery protection. XB5358A contains advanced power MOSFET, high-accuracy voltage detection circuits and delay circuits. XB5358A is put into an ultra-small SOT23-5 package and only one external component makes it an ideal solution in limited space of battery pack. XB5358A has all the protection functions required in the battery application including overcharging, overdischarging, overcurrent and load short circuiting protection etc. The accurate overcharging detection voltage ensures safe and full utilization charging. The low standby current drains little current from the cell while in storage. The device is not only targeted for digital cellular phones, but also for any other Li-Ion and Li-Poly battery-powered information appliances requiring long-term battery life.

## FEATURES

- Protection of Charger Reverse Connection
- Protection of Battery Cell Reverse Connection
- Integrate Advanced Power MOSFET with Equivalent of  $45\text{m}\Omega$   $R_{DS(ON)}$
- Ultra-small SOT23-5 Package
- Only One External Capacitor Required
- Over-temperature Protection
- Overcharge Current Protection
- Two-step Overcurrent Detection:
  - Overdischarge Current
  - Load Short Circuiting
- Charger Detection Function
- 0V Battery Charging Function
- Delay Times are generated inside
- High-accuracy Voltage Detection
- Low Current Consumption
  - Operation Mode:  $2.8\mu\text{A}$  typ.
  - Power-down Mode:
    - XB5358A0  $1.5\mu\text{A}$  typ.
    - XB5358A1  $0.1\mu\text{A}$  typ.
- RoHS Compliant and Lead (Pb) Free

## APPLICATIONS

- One-Cell Lithium-ion Battery Pack
- Lithium-Polymer Battery Pack

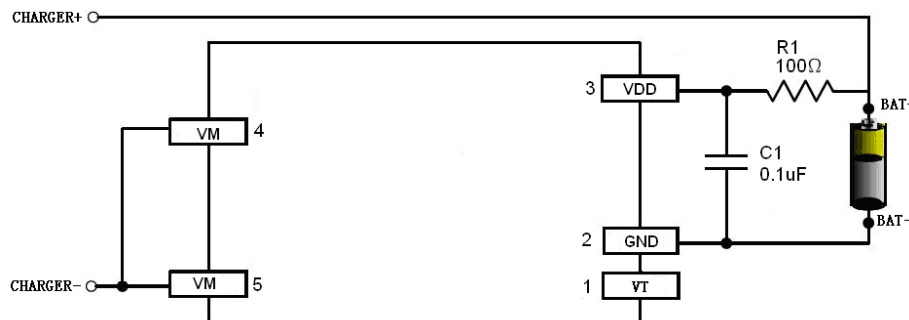


Figure 1. Typical Application Circuit

## ORDERING INFORMATION

| PART NUMBER | Package | Overcharge Detection Voltage [V <sub>cu</sub> ] (V) | Overcharge Release Voltage [V <sub>cl</sub> ] (V) | Overdischarge Detection Voltage [V <sub>dl</sub> ] (V) | Overdischarge Release Voltage [V <sub>dr</sub> ] (V) | Overcurrent Detection Current [I <sub>ov1</sub> ] (A) | Top Mark                  |
|-------------|---------|---|---|--|--|---|---------------------------|
| XB5358A     | SOT23-5 | 4.30  | 4.10  | 2.40   | 3.0  | 3   | 5358AYW <sub>(note)</sub> |

Note: "YW" is manufacture date code, "Y" means the year, "W" means the week

XB5358A0、XB5358A1 has the same top marks , but different in product name pasted on packages.

## PIN CONFIGURATION

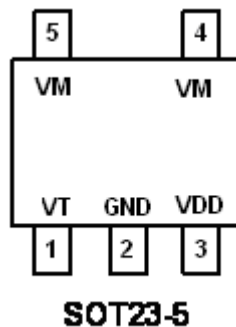


Figure 2. PIN Configuration

## PIN DESCRIPTION

| XB5358A PIN NUMBER | PIN NAME | PIN DESCRIPTION  |
|--------------------|----------|--|
| 1                  | V T      | Test pin ; only for vendor,not used by application   |
| 2                  | GND      | Ground, connect the negative terminal of the battery to this pin                                 |
| 3                  | VDD      | Power Supply   |
| 4,5                | VM       | The negative terminal of the battery pack. The internal FET switch connects this terminal to GND |

## ABSOLUTE MAXIMUM RATINGS

(Note: Do not exceed these limits to prevent damage to the device. Exposure to absolute maximum rating conditions for long periods may affect device reliability.)

| PARAMETER             | VALUE     | UNIT |
|-----------------------|-----------|------|
| VDD input pin voltage | -0.3 to 6 | V    |
| VM input pin voltage  | -6 to 10  | V    |

|  |            |      |
|--|------------|------|
| Operating Ambient Temperature                                  | -40 to 85  | °C   |
| Maximum Junction Temperature                                   | 125        | °C   |
| Storage Temperature  | -55 to 150 | °C   |
| Lead Temperature ( Soldering, 10 sec)                          | 300        | °C   |
| Power Dissipation at T=25°C                                    | 0.4        | W    |
| Package Thermal Resistance (Junction to Ambient) $\theta_{JA}$ | 250        | °C/W |
| Package Thermal Resistance (Junction to Case) $\theta_{JC}$    | 130        | °C/W |
| ESD  | 2000       | V    |

## ELECTRICAL CHARACTERISTICS

Typicals and limits appearing in normal type apply for  $T_A = 25^{\circ}\text{C}$ , unless otherwise specified

| Parameter                                   | Symbol       | Test Condition                   | Min   | Typ          | Max  | Unit       |
|---|--------------|----------------------------------|-------|--------------|------|------------|
| <b>Detection Voltage</b>                    |              |                                  |       |              |      |            |
| Overcharge Detection Voltage                | $V_{CU}$     |                                  | 4.25  | 4.30         | 4.35 | V          |
| Overcharge Release Voltage                  | $V_{CL}$     |                                  | 4.05  | 4.10         | 4.15 | V          |
| Overdischarge Detection Voltage             | $V_{DL}$     |                                  | 2.3   | 2.4          | 2.5  | V          |
| Overdischarge Release Voltage               | $V_{DR}$     |                                  | 2.9   | 3.0          | 3.1  | V          |
| Charger Detection Voltage                   | $V_{CHA}$    |                                  | -0.07 | -0.12        | -0.2 | V          |
| <b>Detection Current</b>                    |              |                                  |       |              |      |            |
| Overdischarge Current1 Detection            | $I_{IOV1}$   | $V_{DD}=3.5V$                    | 2.1   | 3            | 3.9  | A          |
| Load Short-Circuiting Detection             | $I_{SHORT}$  | $V_{DD}=3.5V$                    | 10    | 20           | 30   | A          |
| <b>Current Consumption</b>                  |              |                                  |       |              |      |            |
| Current Consumption in Normal Operation     | $I_{OPE}$    | $V_{DD}=3.5V$<br>$V_M=0V$        |       | 2.8          | 6    | $\mu A$    |
| Current Consumption in power Down           | $I_{PDN}$    | $V_{DD}=2.0V$<br>VM pin floating |       | 1.5*<br>0.1* |      | $\mu A$    |
| <b>VM Internal Resistance</b>               |              |                                  |       |              |      |            |
| Internal Resistance between VM and $V_{DD}$ | $R_{VMD}$    | $V_{DD}=3.5V$<br>$V_M=1.0V$      |       | 320          |      | k $\Omega$ |
| Internal Resistance between VM and GND      | $R_{VMS}$    | $V_{DD}=2.0V$<br>$V_M=1.0V$      |       | 100          |      | k $\Omega$ |
| <b>FET on Resistance</b>                    |              |                                  |       |              |      |            |
| Equivalent FET on Resistance                | $R_{DS(ON)}$ | $V_{DD}=3.6V$ $I_{VM}=1.0A$      | 40    | 45           | 55   | m $\Omega$ |
| <b>Over Temperature Protection</b>          |              |                                  |       |              |      |            |

|  |             |                      |  |     |  |                    |
|--|-------------|----------------------|--|-----|--|--------------------|
| Over Temperature Protection                | $T_{SHD+}$  |                      |  | 120 |  | $^{\circ}\text{C}$ |
| Over Temperature Recovery Degree           | $T_{SHD-}$  |                      |  | 100 |  |                    |
| <b>Detection Delay Time</b>                |             |                      |  |     |  |                    |
| Overcharge Voltage Detection Delay Time    | $t_{CU}$    |                      |  | 130 |  | mS                 |
| Overdischarge Voltage Detection Delay Time | $t_{DL}$    |                      |  | 40  |  | mS                 |
| Overdischarge Current Detection Delay Time | $t_{IOV}$   | $V_{DD}=3.5\text{V}$ |  | 10  |  | mS                 |
| Load Short-Circuiting Detection Delay Time | $t_{SHORT}$ | $V_{DD}=3.5\text{V}$ |  | 75  |  | $\mu\text{S}$      |

\*:XB5358A0 Overdischarge Auto-Release, IPDN=1.5 $\mu\text{A}$  Typ  
 XB5358A1 Overdischarge Latch, IPDN=0.1 $\mu\text{A}$  Typ

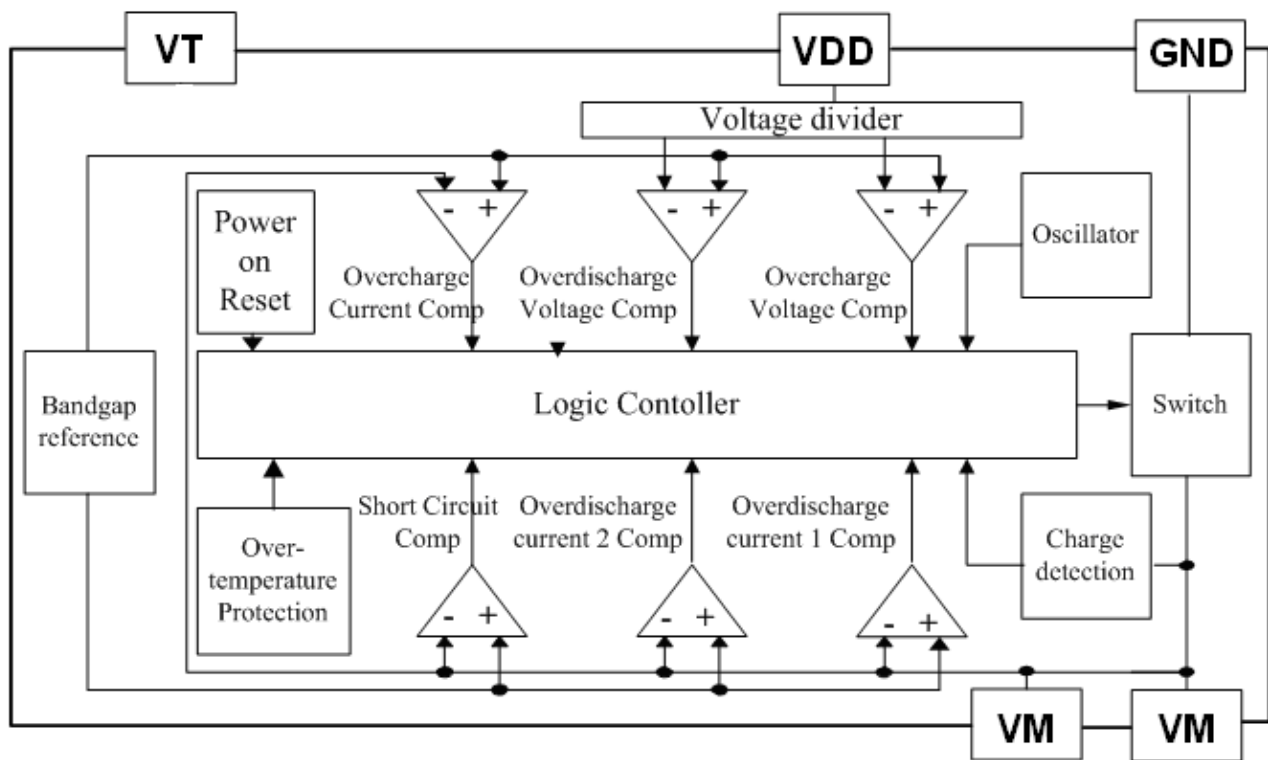


Figure 3. Functional Block Diagram

## FUNCTIONAL DESCRIPTION

The XB5358A monitors the voltage and current of a battery and protects it from being damaged due to overcharge voltage, overdischarge voltage, overdischarge current, and short circuit conditions by disconnecting the battery from the load or charger. These functions are required in

order to operate the battery cell within specified limits.

The device requires only one external capacitor. The MOSFET is integrated and its  $R_{DS(ON)}$  is as low as 45m $\Omega$  typical.

### Normal operating mode

If no exception condition is detected, charging and discharging can be carried

out freely. This condition is called the normal operating mode.

## Overcharge Condition

When the battery voltage becomes higher than the overcharge detection voltage ( $V_{CU}$ ) during charging under normal condition and the state continues for the overcharge detection delay time ( $t_{CU}$ ) or longer, the XB5358A turns the charging control FET off to stop charging. This condition is called the overcharge condition. The overcharge condition is released in the following two cases:

- 1, When the battery voltage drops below the overcharge release voltage ( $V_{CL}$ ), the XB5358A turns the charging control FET on and returns to the normal condition.
- 2, When a load is connected and discharging starts, the XB5358A turns the charging control FET on and returns to the normal condition. The release mechanism is as follows: the discharging current flows through an internal parasitic diode of the charging FET immediately after a load is connected and discharging starts, and the VM pin voltage increases about 0.7 V (forward voltage of the diode) from the GND pin voltage momentarily. The XB5358A detects this voltage and releases the overcharge condition. Consequently, in the case that the battery voltage is equal to or lower than the overcharge detection voltage ( $V_{CU}$ ), the XB5358 returns to the normal condition immediately, but in the case the battery voltage is higher than the overcharge detection voltage ( $V_{CU}$ ), the chip does not return to the normal condition until the battery voltage drops below the overcharge detection voltage ( $V_{CU}$ ) even if the load is connected. In addition, if the VM pin voltage is equal to or lower than the overcurrent 1 detection voltage when a load is connected and discharging starts, the chip does not return to the normal condition.

**Remark** If the battery is charged to a voltage higher than the overcharge detection voltage ( $V_{CU}$ ) and the battery voltage does not drop below the overcharge detection voltage ( $V_{CU}$ ) even when a heavy load, which causes an overcurrent, is connected, the overcurrent 1 and overcurrent 2 do not work until the battery voltage drops below the overcharge detection voltage ( $V_{CU}$ ). Since an actual battery has, however, an internal impedance of several dozens of  $m\Omega$ , and the battery voltage drops immediately after a heavy load which causes an overcurrent is connected, the overcurrent 1 and overcurrent 2 work. Detection of load short-circuiting works regardless of the battery voltage.

## Overdischarge Condition

When the battery voltage drops below the overdischarge detection voltage ( $V_{DL}$ ) during discharging under normal condition and it continues for the overdischarge detection delay time ( $t_{DL}$ ) or longer, the XB5358A turns the discharging control FET off and stops discharging. This condition is called overdischarge condition. After the discharging control FET is turned off, the VM pin is pulled up by the  $R_{VMD}$  resistor between VM and VDD in XB5358A. Meanwhile when VM is bigger than 1.5 V (typ.) (the load short-circuiting detection voltage), the current of the chip is reduced to the power-down current ( $I_{PDN}$ ). This condition is called power-down condition. The VM and VDD pins are shorted by the  $R_{VMD}$  resistor in the IC under the overdischarge and power-down conditions. The power-down condition is released when a charger is connected and the potential difference between VM and VDD becomes 1.3 V (typ.) or higher (load short-circuiting detection voltage). At this time, the FET is still off. When the battery voltage becomes the overdischarge detection voltage ( $V_{DL}$ ) or higher (see note), the XB5358A turns the FET on and changes to the normal condition from the overdischarge condition.

**Remark** If the VM pin voltage is no less than the

charger detection voltage ( $V_{CHA}$ ), when the battery under overdischarge condition is connected to a charger, the overdischarge condition is released (the discharging control FET is turned on) as usual, provided that the battery voltage reaches the overdischarge release voltage ( $V_{DU}$ ) or higher.

### **Overcurrent Condition**

When the discharging current becomes equal to or higher than a specified value (the VM pin voltage is equal to or higher than the overcurrent detection voltage) during discharging under normal condition and the state continues for the overcurrent detection delay time or longer, the XB5358A turns off the discharging control FET to stop discharging. This condition is called overcurrent condition. (The overcurrent includes overcurrent, or load short-circuiting.)

The VM and GND pins are shorted internally by the  $R_{VMS}$  resistor under the overcurrent condition. When a load is connected, the VM pin voltage equals the VDD voltage due to the load.

The overcurrent condition returns to the normal condition when the load is released and the impedance between the B+ and B- pins becomes higher than the automatic recoverable impedance. When the load is removed, the VM pin goes back to the GND potential since the VM pin is shorted the GND pin with the  $R_{VMS}$  resistor. Detecting that the VM pin potential is lower than the overcurrent detection voltage ( $V_{IOV1}$ ), the IC returns to the normal condition.

### **Abnormal Charge Current Detection**

If the VM pin voltage drops below the charger detection voltage ( $V_{CHA}$ ) during charging under the normal condition and it continues for the overcharge detection delay time ( $t_{CU}$ ) or longer, the XB5358A turns the charging control FET off and

stops charging. This action is called abnormal charge current detection. Abnormal charge current detection works when the discharging control FET is on and the VM pin voltage drops below the charger detection voltage ( $V_{CHA}$ ). When an abnormal charge current flows into a battery in the overdischarge condition, the XB5358A consequently turns the charging control FET off and stops charging after the battery voltage becomes the overdischarge detection voltage and the overcharge detection delay time ( $t_{CU}$ ) elapses.

Abnormal charge current detection is released when the voltage difference between VM pin and GND pin becomes lower than the charger detection voltage ( $V_{CHA}$ ) by separating the charger. Since the 0 V battery charging function has higher priority than the abnormal charge current detection function, abnormal charge current may not be detected by the product with the 0 V battery charging function while the battery voltage is low.

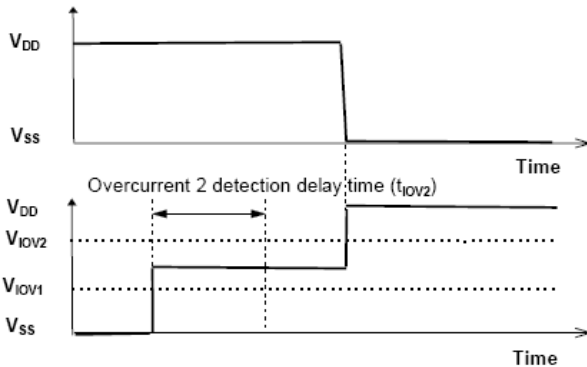
### **Load Short-circuiting condition**

If voltage of VM pin is equal or below short circuiting protection voltage ( $V_{SHORT}$ ), the XB5358A will stop discharging and battery is disconnected from load. The maximum delay time to switch current off is  $t_{SHORT}$ . This status is released when voltage of VM pin is higher than short protection voltage ( $V_{SHORT}$ ), such as when disconnecting the load.

### **Delay Circuits**

The detection delay time for overdischarge current 2 and load short-circuiting starts when overdischarge current 1 is detected. As soon as overdischarge current 2 or load short-circuiting is detected over detection delay time for overdischarge current 2 or load short-circuiting, the XB5358A stops

discharging. When battery voltage falls below overdischarge detection voltage due to overdischarge current, the XB5358A stop discharging by overdischarge current detection. In this case the recovery of battery voltage is so slow that if battery voltage after overdischarge voltage detection delay time is still lower than overdischarge detection voltage, the XB5358A shifts to power-down.



**Figure 4. Overcurrent delay time**

### 0V Battery Charging Function <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup>

This function enables the charging of a connected battery whose voltage is 0 V by self-discharge. When a charger having 0 V battery start charging charger voltage ( $V_{OCHA}$ ) or higher is connected between B+

and B- pins, the charging control FET gate is fixed to VDD potential. When the voltage between the gate and the source of the charging control FET becomes equal to or higher than the turn-on voltage by the charger voltage, the charging control FET is turned on to start charging. At this time, the discharging control FET is off and the charging current flows through the internal parasitic diode in the discharging control FET. If the battery voltage becomes equal to or higher than the overdischarge release voltage ( $V_{DU}$ ), the normal condition returns.

#### Note

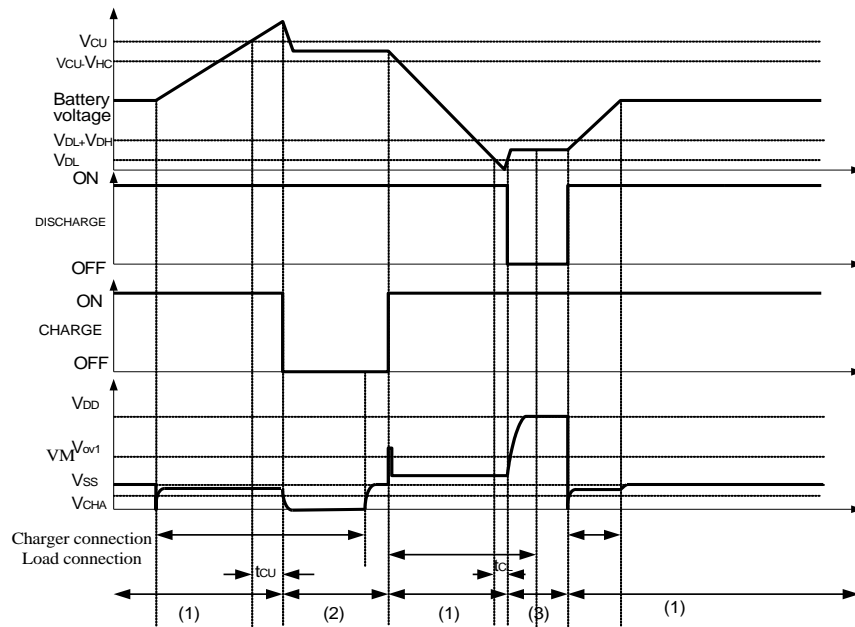
**(1)** Some battery providers do not recommend charging of completely discharged batteries. Please refer to battery providers before the selection of 0 V battery charging function.

**(2)** The 0V battery charging function has higher priority than the abnormal charge current detection function. Consequently, a product with the 0 V battery charging function charges a battery and abnormal charge current cannot be detected during the battery voltage is low (at most 1.8 V or lower).

**(3)** When a battery is connected to the IC for the first time, the IC may not enter the normal condition in which discharging is possible. In this case, set the VM pin voltage equal to the GND voltage (short the VM and GND pins or connect a charger) to enter the normal condition.

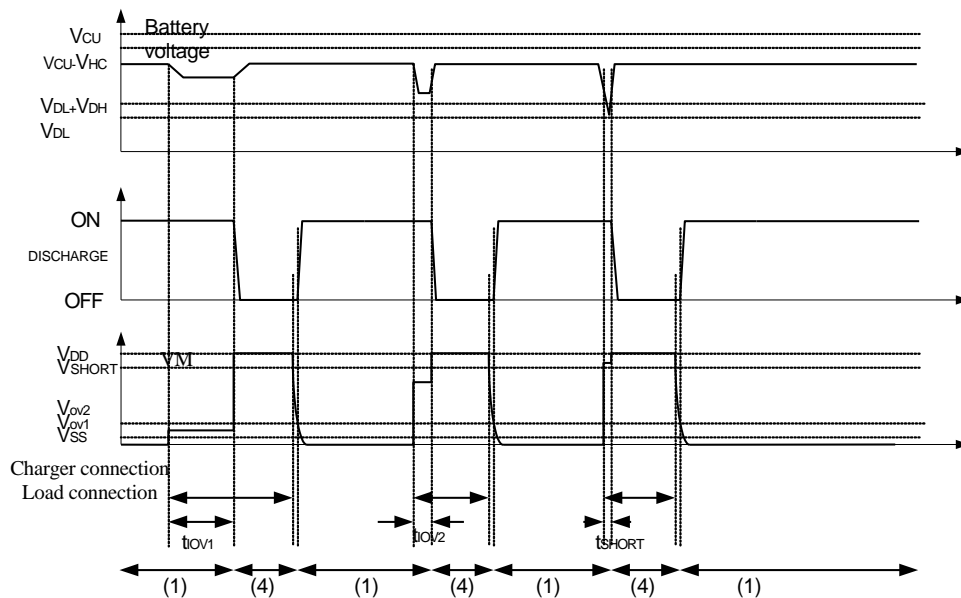
# TIMING CHART

## 1. Overcharge and overdischarge detection



**Figure5-1 Overcharge and Overdischarge Voltage Detection**

## 2. Overdischarge current detection

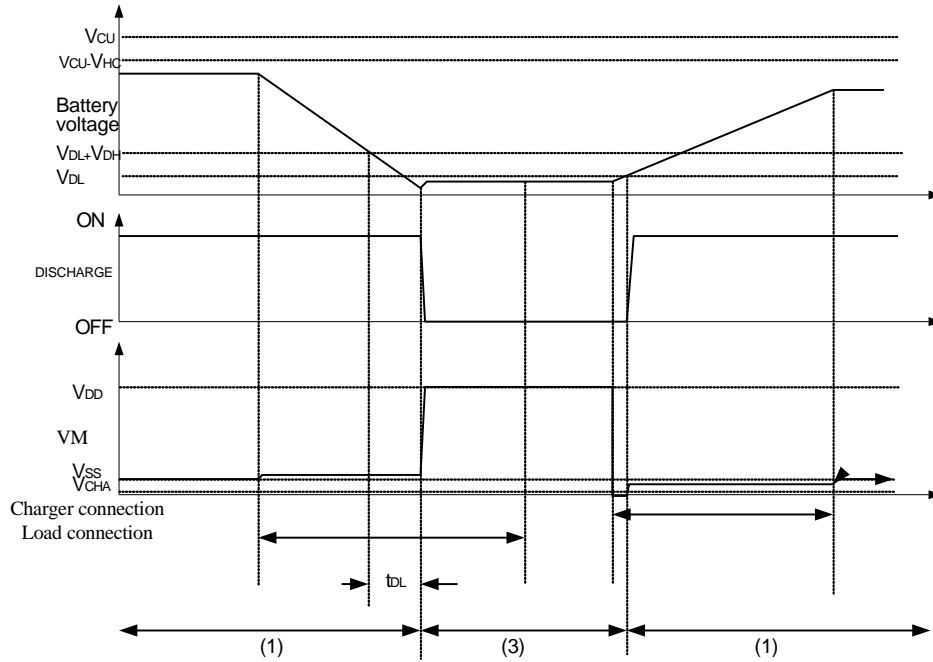


**Figure5-2 Overdischarge Current Detection**

Remark: (1) Normal condition (2) Overcharge voltage condition (3) Overdischarge voltage condition (4) Overcurrent condition

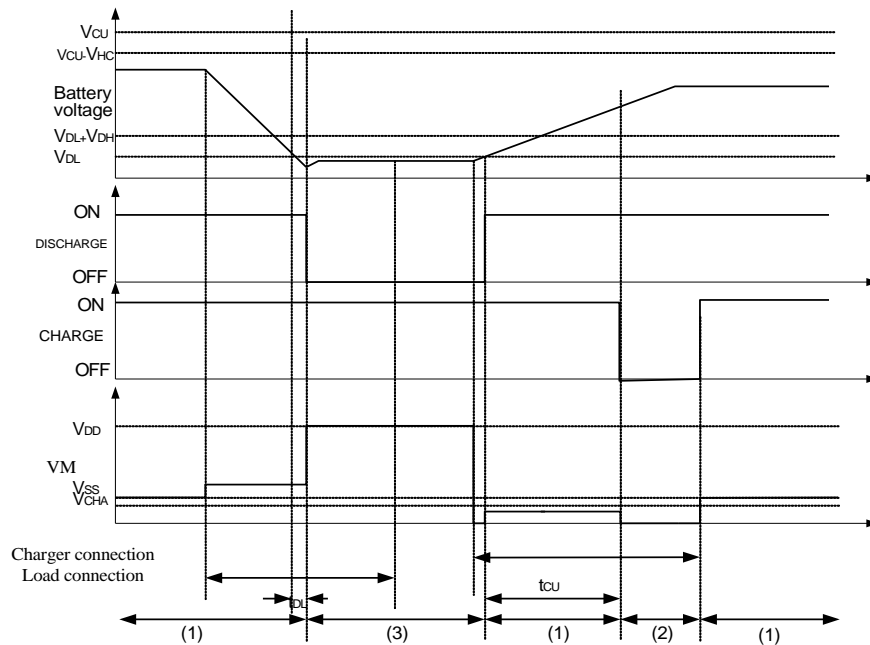


### 3. Charger Detection



**Figure5-3 Charger Detection**

### 4. Abnormal Charger Detection



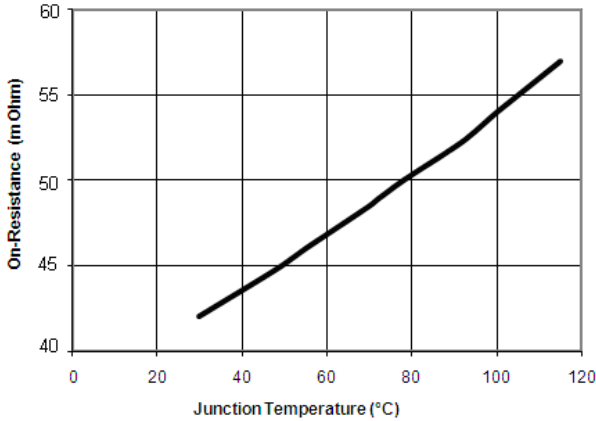
**Figure5-4 Abnormal Charger Detection**

Remark: (1) Normal condition (2) Overcharge voltage condition (3) Overdischarge voltage condition (4) Overcurrent condition

## TYPICAL CHARACTERISTICS

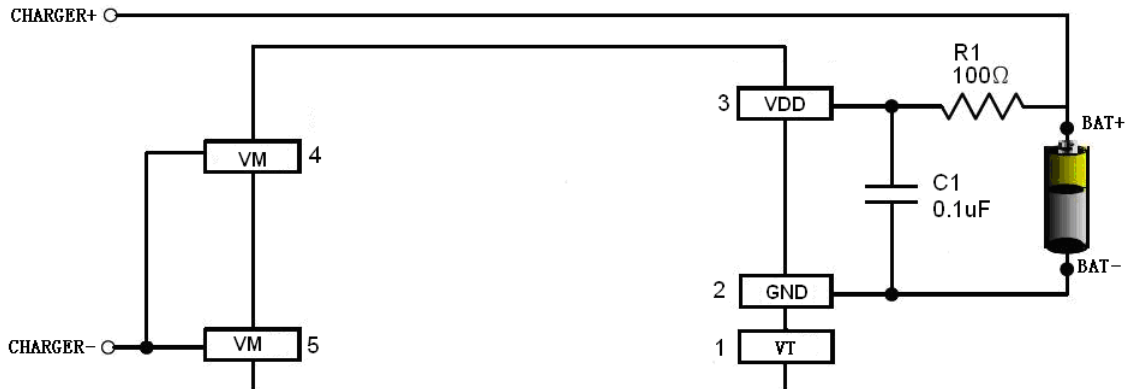
(Test based on XB5358A version,  $V_{BAT} = 3.6V$ ,  $T_A = 25^\circ C$  unless otherwise specified)

### Internal FET On-Resistance vs. Junction Temperature



## TYPICAL APPLICATION

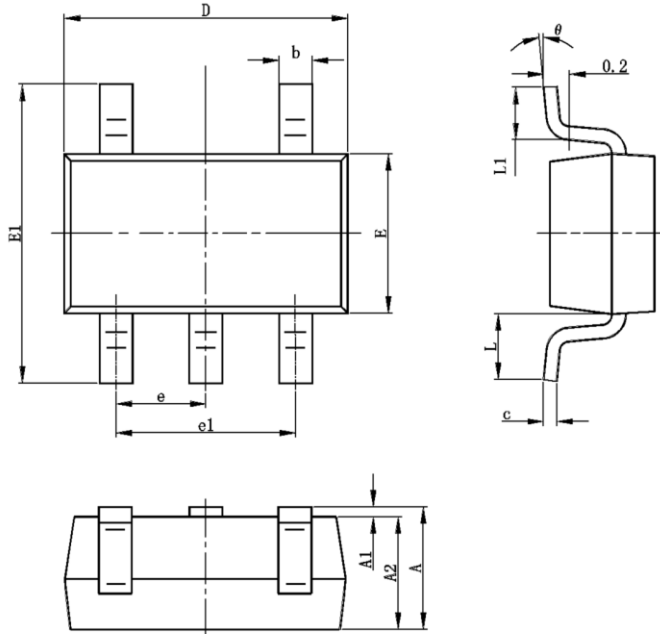
As shown in Figure 6, the bold line is the high density current path which must be kept as short as possible. For thermal management, ensure that these trace widths are adequate. C1 is a decoupling capacitor which should be placed as close as possible to XB5358A.



**Fig 6 XB5358A in a Typical Battery Protection Circuit**

### Precautions

- Pay attention to the operating conditions for input/output voltage and load current so that the power loss in XB5358A does not exceed the power dissipation of the package.
- Do not apply an electrostatic discharge to this XB5358A that exceeds the performance ratings of the built-in electrostatic protection circuit.

**PACKAGE OUTLINE**
**SOT23-5 PACKAGE OUTLINE AND DIMENSIONS**


| SYMBOL | DIMENSION IN MILLIMETERS |       | DIMENSION IN INCHES |       |
|--------|--------------------------|-------|---------------------|-------|
|        | MIN                      | MAX   | MIN                 | MAX   |
| A      | 1.050                    | 1.250 | 0.041               | 0.049 |
| A1     | 0.000                    | 0.100 | 0.000               | 0.004 |
| A2     | 1.050                    | 1.150 | 0.041               | 0.045 |
| b      | 0.300                    | 0.400 | 0.012               | 0.016 |
| c      | 0.100                    | 0.200 | 0.004               | 0.008 |
| D      | 2.820                    | 3.020 | 0.111               | 0.119 |
| E      | 1.500                    | 1.700 | 0.059               | 0.067 |
| E1     | 2.650                    | 2.950 | 0.104               | 0.116 |
| e      | 0.950 TYP                |       | 0.037 TYP           |       |
| e1     | 1.800                    | 2.000 | 0.071               | 0.079 |
| L      | 0.700 REF                |       | 0.028 REF           |       |
| L1     | 0.300                    | 0.600 | 0.012               | 0.024 |
| θ      | 0°                       | 8°    | 0°                  | 8°    |

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